

Fig. 1. Ratios  $F_M/F_f$  against  $\theta$ . Dots represent ratios derived by use of  $p_K$ , and triangles show ratios resulting from  $p = 0.65p_D + 0.35p_K$ . The curve gives  $(p_K/(0.65p_D + 0.35p_K))^{1/2}$  as a function of  $\theta$ .

skewness in background at lower  $\theta$  angles, in part resulting from background measurements being made at points where 'white' radiation is strongly absorbed by the filter, giving rise to underestimated background values.

The possibility of an intensity-related error was ruled out by comparing  $F_M$  with  $F_f$  as a function of F, with no systematic trend apparent. An R index of 0.010 (R=2-

 $(\Sigma |F_M - F_f|)/\Sigma (F_M + F_f))$  calculated for the reflections used indicates a very satisfactory overall agreement between the two data sets.

The results obtained in this study show that commercially available graphite monochromators can behave quite differently from 'ideally imperfect' crystals, and that allowance should be made for any departure from ideal behavior. Each monochromator must of course be calibrated; it is also conceivable that the calibration might change as a result of irradiation.

This study was supported through a grant from the National Science Foundation. Thanks are due Krista T. Black for help with the calculations.

#### Reference

AZÁROFF, L. V. (1955). Acta Cryst. 8, 701. HOPE, H. & VICTOR, D. (1969). Acta Cryst. B25, 1849. MIYAKE, S. & TOGAWA, S. (1964). Acta Cryst. 17, 1083.

## **International Union of Crystallography**

## Commission on Crystallographic Computing

# Call for material for the third edition of the World List of Cryrstallographic Computer Programs

The Commission on Crystallographic Computing of the International Union of Crystallography wishes to announce its decision to prepare a third edition of the *World List of Crystallographic Computer Programs*. The Editor in charge of this edition is

Dr G. C. Bassi

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Suitable publication of the *List* will be arranged. The *Journal of Applied Crystallography* is being considered as a possible publication medium. Authors and/or distributors of crystallographic computer programs or systems are invited to submit the necessary information about their programs to the Editor, G. C. Bassi, by 1 November 1971, or earlier if possible. Formats for the submission cards are described below; if punched-card equipment is not available the information may be presented on sheets in the prescribed formats.

All material to be included in the third edition will be based only on the newly submitted cards (or sheets), regardless of whether or not the programs are included in the second edition. It is hoped that this will encourage programmers to eliminate any programs which are out of date, or of very limited interest. In general, only programs that are well checked and in good running order will be accepted. Proper documentation is essential, and the Editor urges those submitting programs to ensure that they will be well documented by the time of publication of the World List.

#### Required information

(a) A Title card, a Name and Source card, and six or less Abstract cards are needed for each program.

(b) An Author Index card should be submitted for each author, programmer, and distributor of programs. When one of these names is abbreviated in the Title or Name cards, an additional Author Index card should be supplied, giving the full name as in the following example:

SHMKR, SEE SHØEMAKER, D. P. SHØEMAKER, D. P., ØREGØN STATE UNIVER-SITY, CØRVALLIS, ØREGØN 97331, U.S.A.

(c) A Definition card should be included for each abbreviated function, machine, language, or system that has been used but is not already included in the list of abbreviations supplied.

#### **Formats**

Title card Card columns Contents

- 1- 4 Program accession number, to be assigned by the Editor. Programs are numbered serially in chronological order of receipt by the Editor.
- 6-13 Machine type, by code name or number.
- 15-22 Language in which the program is written.
- 24–31 Crystallographic computer system, and the program number or identification within the system, as for example XRAY-23, XRY 70-23, or NRC-10.
- 33-64 Program name, and functions in coded form chosen from the supplied abbreviation list. If necessary only use new symbols defined in a Definition card. The name should be followed by a comma, and the functions should be separated by a blank space. The functions should serve as identification of the types of calculation included in the program. Example:

POW, HKL DHK DST

DIF

**PRO** 

means that the program generates the indices H, calculates the d-spacings, and sorts the reflections in descending order of d(H). The functions may be omitted if desired.

- 66-67 Core requirement in K words for the program as supplied, where K=1024.
- 69-75 Name of distributor or person in charge of the program to whom enquiries should be addressed.
  - 78 Status of program operability, and availability of program code:
    - L well checked out, program code available
      M well checked out, program code not available
      N operable but not well checked out.
  - 79 Status of program write-up:
    - C complete write-up available, with the algorithms and the input/output explained.
    - I write-up available for input/output only

N no write-up available

- 80 Status of availability of program in working form:
  A available on request for no charge
  - C available for the charge stated in the abstract.
  - N not available at present, probably available at
  - S program is of special or local nature, conditionally available.

#### Name and Source card

- 1- 4 Program accession number, same as on the Title card.
  - 5 1 (a card sequence number of identification).
- 6-40 Authors, programmers' names. Only surnames should be given except when use of an initial is necessary to avoid confusion. Surnames should be separated by commas. Where initials are needed they should follow the surname, separated by spaces but no punctuation. The person to whom technical enquiries should be addressed should have an asterisk after his surname if he is not the first author. The name of the distributor should be omitted from this card unless he is one of the authors.
- 42-75 Source. If the program happens to be a modification of another program, the original program and authors should be identified; otherwise this space should be left blank.

#### Abstract cards

- 1- 4 Program accession number, the same as on the Title card.
  - 5 2 ... 7 (a card sequence number for identifica tion).
- 8-75 Abstract, limited to about 50 words. It should include the relevant information which cannot be directly identified from the program title such as special features, speed, and generality.

## Author Index card

1-80 Surname starting in column 1, initials, and mailing address. All name abbreviations should be explained on additional cards.

#### Definition card

- 1-10 The abbreviation used, starting in col. 1.
- 11-80 Full meaning.

## PROGRAM AND FUNCTION ABBREVIATIONS

## Space group generalities

- ASG ALL SPACE GROUPS
- CSP CENTROSYMMETRIC SPACE GROUPS ONLY
- NSG NON-CENTROSYMMETRIC SPACE GROUPS ONLY
- PRI PRIMITIVE UNIT CELLS ONLY
  TMO TRICLINIC, MONOCLINIC, AND
  ORTHORHOMBIC SYSTEMS ONLY

#### LAT Lattice constants

- LCD LATTICE CONSTANTS DETERMINATION LCR LATTICE CONSTANTS REFINEMENT
- RUC REDUCTION OF UNIT CELL

#### Diffractometer control

CCD COMPUTER CONTROLLED

DIFFRACTOMETER

- CIR 3 OR 4 CIRCLE GEOMETRY
- GSC GONIOSTAT SETTINGS CALCULATION
- HKL GENERATE THE INDICES
- OMC ORIENTATION MATRIX CALCULATION OMR ORIENTATION MATRIX REFINEMENT
- WEI WEISSENBERG GEOMETRY

#### Processing of raw intensity data

- AVG AVERAGING OF INTENSITIES
- CMP COMPARISON OF MULTIPLE
  - MEASUREMENTS
- OUA OBS/UNOBS ASSIGNMENT
- LAY SCALING ACCORDING TO LAYERS
- NET CALCULATION OF NET COUNTS
- SCH SEARCH FOR UNMEASURED REFLEXIONS
- SCL SCALING OF THE INTENSITIES
- SRT SORT ON THE INDICES

## DRF Data reduction and generation of data file

- ABS ABSORPTION CORRECTIONS
- ACT ACENTRIC-CENTRIC TEST
- CIR 3 OR 4 CIRCLE GONIOSTAT GEOMETRY
- FOB F OBS CALCULATION
- ISC INTERPOLATION ON SCATTERING
  - FACTOR CURVES
- LPC LORENTZ AND POLARIZATION
  - **CORRECTIONS**
- PRC PRECESSION GEOMETRY
- SHF SHARPENING FUNCTION APPLICATION
- WEI WEISSENBERG GEOMETRY
- WSN WILSON STATISTICS
- WTA WEIGHT ASSIGNMENT

## DIR Direct phasing

- EHS NORMALIZED STRUCTURE FACTORS
- AND STATISTICS
- MLT MULTISOLUTION PROCEDURE
- OES ORIGIN AND ENANTIOMORPH SELECTION
- ORG ORIGIN SELECTION
- PAS PHASE ESTIMATION FROM ANOMALOUS SCATTERING
- PIA PHASE ESTIMATION FROM ISOM. REPL. AND ANOM. SCAT.

PIR	PHASE ESTIMATION FROM	ABI	ABSORPTION CORRECTION BY
	ISOMORPHOUS REPLACEMENT		GAUSSIAN INTEGRATION
PLS	PHASE ESTIMATION BY LEAST	ABE	ABSORPTION CORRECTION BY
PLS		ADL	
	SQUARES		EXPERIMENTAL METHOD
PST	PHASE REFINEMENT BY THE SQUARED	LPC	LORENTZ AND POLARIZATION
	TANGENT FORMULA		CORRECTIONS
PTN	PHASE REFINEMENT BY THE TANGENT	MPD	CORRECTION FOR MULTIPLE
	FORMULA		DIFFRACTION
SAP	SYMBOLIC ADDITION PROCEDURE	PEX	CORRECTION FOR PRIMARY
		ILA	EXTINCTION
SIC	STRUCTURE INVARIANT CALCULATION	ODA/	
STF	SCALE AND TEMPERATURE FACTOR	SEX	CORRECTION FOR SECONDARY
	ESTIMATION		EXTINCTION
SYR	SAYRE'S EQUATION APPLICATION	EED	Title - 1945
SII	SIGMA 1 INTERACTIONS SEARCH	FED	File editing and manipulation
S2I	SIGMA 2 INTERACTIONS SEARCH	ADL	ADD TO OR DELETE FROM FILE
USF	UNITARY STRUCTURE FACTORS	FST	FILE SORT ON THE INDICES
CSI	OMIAKI BIROCIORE I MCIORB	GRT	GENERATE EQUIVALENT REFLEXIONS
SCF	Scattering factor determination	0211	IN HIGH SYMMETRY SPACE GROUPS
	_	PRT	PRINT FILE CONTENTS
ISC	INTERPOLATION ON SCATTERING	FKI	FRINT FILE CONTENTS
	FACTOR CURVES	REF	Refinement of atomic parameters
NSC	NEUTRON SCATTERING FACTOR		<del>_</del>
	DETERMINATION	BIJ	REFINEMENT OF ANISOTROPIC
XSC	X-RAY SCATTERING FACTOR		THERMAL PARAMETERS
ASC	DETERMINATION	BIS	REFINEMENT OF ISOTROPIC
	DETERMINATION		THERMAL PARAMETERS
SFC	Structure factor calculation	BLS	BLOCK DIAGONAL LEAST SQUARES
SEC		DFS	REFINEMENT BY DIFFERENTIAL
AGA	AGREEMENT ANALYSIS OF OBS & CALC	DES	
	DATA		SYNTHESES
SAD	STRUCTURE FACTORS WITH	DLS	DIAGONAL LEAST SQUARES
DAID	ANOMALOUS DISPERSION	ESD	CALCULATION OF THE ESTIMATED
CANI			STANDARD DEVIATIONS
SAN	STRUCTURE FACTORS WITH ANISO-	FDG	APPLICATION OF FUDGE OR
	TROPIC THERMAL PARAMETERS		RELAXATION FACTORS
SIS	STRUCTURE FACTORS WITH ISOTRO-	FLS	FULL MATRIX LEAST SQUARES
	PIC THERMAL PARAMETERS		
SFO	S.F. WITH FRACTIONAL OCCUPANCIES	LAD	LEAST SQUARES WITH ANOMALOUS
SFT	S.F. TRIALS BY ADDITION OR		DISPERSION
51 1	SUBTRACTION OF ATOMS	LAY	REFINEMENT OF LAYER SCALE
CD.C	CONTRIBUTION OF RIGID GROUP		FACTORS
SRG	CONTRIBUTION OF RIGID GROUP	LEQ	LEAST SQUARES FOR ATOMS WITH
FOU	Fourier type calculation		EQUIVALENT COORDINATES
	- <b>-</b>	* 0.0	
FBL	ECTIBIED WITH DEEVEDS LIDSON TVDE	LSP	LEAST SOLIARES WITH ALLOWANCE FOR
	FOURIER WITH BEEVERS-LIPSON TYPE	LSP	LEAST SQUARES WITH ALLOWANCE FOR
	CALCULATION		ATOMS IN SPECIAL POSITIONS
FCT	CALCULATION	OCC	ATOMS IN SPECIAL POSITIONS REFINEMENT OF OCCUPANCY FACTORS
FCT	CALCULATION FOURIER BY COOLEY-TUKEY	OCC RBL	ATOMS IN SPECIAL POSITIONS REFINEMENT OF OCCUPANCY FACTORS RIGID BODY LEAST SQUARES
	CALCULATION FOURIER BY COOLEY-TUKEY ALGORITHM	OCC	ATOMS IN SPECIAL POSITIONS REFINEMENT OF OCCUPANCY FACTORS RIGID BODY LEAST SQUARES SCHOMAKER'S CORRECTION OF
FCT FPD	CALCULATION FOURIER BY COOLEY-TUKEY ALGORITHM FOURIER, PATTERSON & DIFFERENCE	OCC RBL SCH	ATOMS IN SPECIAL POSITIONS REFINEMENT OF OCCUPANCY FACTORS RIGID BODY LEAST SQUARES
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FPD FPS FR1 FR2 FR3 FTM FUM SHF VMS VHA VMF VOS VPS VVR	CALCULATION FOURIER BY COOLEY-TUKEY ALGORITHM FOURIER, PATTERSON & DIFFERENCE SYNTHESES FOURIER PEAK SEARCH ONE-DIMENSIONAL FOURIER TWO-DIMENSIONAL FOURIER THREE-DIMENSIONAL FOURIER FOURIER TRANSFORM FOURIER PRODUCING UNDISTORTED MAPS SHARPENING FUCTION APPLIED  Vector map solving and manipulation VECTOR HEAVY ATOM ANALYSIS VECTOR MINIMUM FUNCTION VECTOR ORIENTATION SEARCH VECTOR VERIFICATION	OCC RBL SCH SCL XYZ GEO DIH MPL POL ROT SAN SID SBL TOR THV	ATOMS IN SPECIAL POSITIONS REFINEMENT OF OCCUPANCY FACTORS RIGID BODY LEAST SQUARES SCHOMAKER'S CORRECTION OF THERMAL PARAMETER SHIFTS REFINEMENT OF OVERALL SCALE FACTOR REFINEMENT OF POSITIONAL PARAMETERS  Molecular geometry calculations DIHEDRAL ANGLE BETWEEN PLANES MEAN PLANE THROUGH A SET OF ATOMS BY LEAST SQUARES COORDINATION POLYHEDRA ROTATION ANGLES SCAN OF ANGLES SCAN OF INTERMOLECULAR DISTANCES SCAN OF BOND LENGTHS TORSIONAL ANGLES  Thermal vibration analysis
FPD FPS FR1 FR2 FR3 FTM FUM SHF VMS VHA VMF VOS VPS VVR COR	CALCULATION FOURIER BY COOLEY-TUKEY ALGORITHM FOURIER, PATTERSON & DIFFERENCE SYNTHESES FOURIER PEAK SEARCH ONE-DIMENSIONAL FOURIER TWO-DIMENSIONAL FOURIER THREE-DIMENSIONAL FOURIER FOURIER TRANSFORM FOURIER PRODUCING UNDISTORTED MAPS SHARPENING FUCTION APPLIED  Vector map solving and manipulation VECTOR HEAVY ATOM ANALYSIS VECTOR MINIMUM FUNCTION VECTOR ORIENTATION SEARCH VECTOR VERIFICATION  Corrections to observed data	OCC RBL SCH SCL XYZ GEO DIH MPL POL ROT SAN SID SBL TOR THV ACC	ATOMS IN SPECIAL POSITIONS REFINEMENT OF OCCUPANCY FACTORS RIGID BODY LEAST SQUARES SCHOMAKER'S CORRECTION OF THERMAL PARAMETER SHIFTS REFINEMENT OF OVERALL SCALE FACTOR REFINEMENT OF POSITIONAL PARAMETERS  Molecular geometry calculations DIHEDRAL ANGLE BETWEEN PLANES MEAN PLANE THROUGH A SET OF ATOMS BY LEAST SQUARES COORDINATION POLYHEDRA ROTATION ANGLES SCAN OF ANGLES SCAN OF INTERMOLECULAR DISTANCES SCAN OF BOND LENGTHS TORSIONAL ANGLES  Thermal vibration analysis ACCUMULANTS
FPD FPS FR1 FR2 FR3 FTM FUM SHF VMS VHA VMF VOS VPS VVR	CALCULATION FOURIER BY COOLEY-TUKEY ALGORITHM FOURIER, PATTERSON & DIFFERENCE SYNTHESES FOURIER PEAK SEARCH ONE-DIMENSIONAL FOURIER TWO-DIMENSIONAL FOURIER THREE-DIMENSIONAL FOURIER FOURIER TRANSFORM FOURIER PRODUCING UNDISTORTED MAPS SHARPENING FUCTION APPLIED  Vector map solving and manipulation VECTOR HEAVY ATOM ANALYSIS VECTOR MINIMUM FUNCTION VECTOR ORIENTATION SEARCH VECTOR POSITION SEARCH VECTOR VERIFICATION  Corrections to observed data APSORPTION CORRECTION BY	OCC RBL SCH SCL XYZ GEO DIH MPL POL ROT SAN SID SBL TOR THV	ATOMS IN SPECIAL POSITIONS REFINEMENT OF OCCUPANCY FACTORS RIGID BODY LEAST SQUARES SCHOMAKER'S CORRECTION OF THERMAL PARAMETER SHIFTS REFINEMENT OF OVERALL SCALE FACTOR REFINEMENT OF POSITIONAL PARAMETERS  Molecular geometry calculations DIHEDRAL ANGLE BETWEEN PLANES MEAN PLANE THROUGH A SET OF ATOMS BY LEAST SQUARES COORDINATION POLYHEDRA ROTATION ANGLES SCAN OF ANGLES SCAN OF INTERMOLECULAR DISTANCES SCAN OF BOND LENGTHS TORSIONAL ANGLES  Thermal vibration analysis ACCUMULANTS CORRECTIONS OF BOND LENGTHS
FPD FPS FR1 FR2 FR3 FTM FUM SHF VMS VHA VMF VOS VPS VVR COR	CALCULATION FOURIER BY COOLEY-TUKEY ALGORITHM FOURIER, PATTERSON & DIFFERENCE SYNTHESES FOURIER PEAK SEARCH ONE-DIMENSIONAL FOURIER TWO-DIMENSIONAL FOURIER THREE-DIMENSIONAL FOURIER FOURIER TRANSFORM FOURIER PRODUCING UNDISTORTED MAPS SHARPENING FUCTION APPLIED  Vector map solving and manipulation VECTOR HEAVY ATOM ANALYSIS VECTOR MINIMUM FUNCTION VECTOR ORIENTATION SEARCH VECTOR VERIFICATION  Corrections to observed data	OCC RBL SCH SCL XYZ GEO DIH MPL POL ROT SAN SID SBL TOR THV ACC	ATOMS IN SPECIAL POSITIONS REFINEMENT OF OCCUPANCY FACTORS RIGID BODY LEAST SQUARES SCHOMAKER'S CORRECTION OF THERMAL PARAMETER SHIFTS REFINEMENT OF OVERALL SCALE FACTOR REFINEMENT OF POSITIONAL PARAMETERS  Molecular geometry calculations DIHEDRAL ANGLE BETWEEN PLANES MEAN PLANE THROUGH A SET OF ATOMS BY LEAST SQUARES COORDINATION POLYHEDRA ROTATION ANGLES SCAN OF ANGLES SCAN OF INTERMOLECULAR DISTANCES SCAN OF BOND LENGTHS TORSIONAL ANGLES  Thermal vibration analysis ACCUMULANTS

PLT RID RIG	AUTOMATIC PLOTTING OF THERMAL ELLIPSOIDS RIDING MOTION RIGID BODY MOTION				CDC 3500 CDC 6600 CDC7600	CDC3500 CDC6600 CDC7600
TEL		HERMAL ELLIPSOIDS CALCULATION		DIGITAL EQUIPMENT	PDP 7	PDP7
SFT	Structure factor tables for publication			PDP 8	PDP8	
AGR	AGREEMENT ANALYSIS OF THE OBS &			PDP 8/I PDP 8/E	PDP8I PDP8E	
CSF	CALC STRUCTURE FACTORS COMPRESSED STRUCTURE FACTOR TABLES FOR PUBLICATION		GENERAL ELECTRIC	PDP 9 <sup>'</sup> GE 615	PDP9 GE615	
PLT	Plotter programs			FE 635 GE 655	GE635 GE655	
FCR DRW TEL	FOURIER CONTOURS STRUCTURE DRAWING THERMAL ELLIPSOIDS			HEWLETT PACKARD	HP 2114 A HP 2115 A	HP2114A HP2115A
POW	Powder diffraction				HP 2116 B	HP2116B
BRG CPP DHK	CALCULATION OF BRAGG ANGLES CALCULATION OF POWDER PATTERN CALCULATION OF INTERPLANAR SPACINGS		HONEYWELL	200/1200 200/1250 200/2200 H 632	H2001200 H2001250 H2002200 H632	
DST	SORTING IN DESCENDING ORDER OF INTERPLANAR SPACINGS			IBM	360/65	IDM2005
HKL IND LCD	GENERATE THE INDICES INDEXING OF POWDER PATTERN LATTICE CONSTANTS DETERMINATION FROM POWDER PATTERN SEARCH OF THE ASTM POWDER FILE				360/50 360/44 360/40 1130 1800	IBM36065 IBM36050 IBM36044 IBM36040 IBM1130 IBM1800
STP	STRUCTURE REFINEMENT FROM			Non		
UCP	POWDER PATTERN BY LEAST SQUARES UNIT CELL REFINEMENT FROM POWDER PATTERN BY LEAST SQUARES			NCR	CENTURY 100 CENTURY 200	
PRJ	Projections of the structures		UNIVAC	1106 1108	UNC1106	
ORT	ORTHOGONAL PROJECTION		VEDOX DATE STREET		UNC1108	
STE	STEREOSCOPIC PROJECTION		XEROX DATA SYSTEMS	SIGMA 3 SIGMA 5	XDSSIG3 XDSSIG5	
MSC	Miscellaneous			SIGMA 6	XDSSIG6	
ASD ATR	ATOMIC STRUCTURE DETERMINATION			TOY	SIGMA 7	XDSSIG7
CCS	ATOMIC RADII CRYSTALLOGRAPHIC COMPUTER SYSTEM ELECTRON DIFFRACTION		ICL	1901 1901 A 1902 A 1903 A	ICL1901 ICL1901A ICL1902A	
MFF	MAGNETIC FORM FACTOR				1904 A	ICL1903A ICL1904A
MSD	DETERMINATION MAGNETIC STRUCTURE DETERMINA-				1906 A KDF 9	ICL1906A ICLKDF9
NDN	TION NEUTRON DIFFRACTION			DILL CE		
PRT	PROTEIN WORK		BULL-GE	415 425	BGE415 BGE425	
REN RTS	RENNINGER EFFECT REAL TIME SYSTEM				435	BGE435
SPW	SIMPLEX METHOD			C.I.I.	510	CII510
TDS VAR XDN	THERMAL DIFFUSE SCATTERING VARIANCE X-RAY DIFFRACTION				90/10 90/40 90/80	CII0910 CII9040 CII9080
					10020	CII10020
	COMPUTER A	ABREVIATIO	NS		10070	CII10070
Name		Type	Abbreviation	SIEMENS	4004/35 4004/45	SI400435 SI400445
BURROUGHS B 500 B 500 B 6500 B 6500			TELEFUNKEN	TR 4	TR4	
CONTROL DATA CDC 3300 CDC3300		CDC3300		TR 86 TR 440	TR86 TR440	

### Commission on Crystallographic Apparatus

## An international project for the calibration of absolute intensities in small-angle X-ray scattering

The importance of absolute intensity measurements in small-angle X-ray experiments has been recognized for many years, and a wide variety of methods have been reported for achieving such calibrations (Luzzati, 1960; Gerold, 1961; Kratky & Wawra, 1963; Damaschun & Müller, 1965; Kratky, Pilz & Schmitz, 1966). Apart from a comparison by Weinberg (1963) of the foil-attenuation method with the gas-scattering method and a comparison by Shaffer (1964) and Shaffer & Beeman (1970) of the data for zero-angle scattering for several gases, there has been no attempt to compare the many techniques. The problem of precision in measurements of absolute intensity, and the need for a comparison of the different techniques for a common standard sample, were discussed at the recent Second International Conference on Small-Angle Scattering of X-rays held in Graz, Austria, in August, 1970. The results of these discussions may be summarized as follows:

- I. An international project should be established with the aims of (1) testing the precision of reproducibility and the comparative accuracy of the various calibration techniques in current use, and (2) clarifying the areas of difficulty in absolute intensity calibration.
- II. There shall be no attempt to nominate a single absolute intensity calibration technique. Each participating laboratory will use its own preferred technique to carry out measurements on a set of standard specimens to be provided by the project organizer.
- III. The secondary standards would be (1) chemically, thermally, and physically stable, (2) unaffected by long exposures to X-rays, (3) easily transported, and (4) easily handled. On the basis of these criteria, liquid samples were eliminated from consideration. Three solid samples were agreed upon as suitable standards: (1) glassy carbon, (2) polyethylene, and (3) cellulose acetate. Each specimen would be mounted in a specimen holder suitable for use in almost all small-angle scattering geometries.
- IV. The project organizer would have the responsibility for (1) designing the specimen holders, (2) preparing the instructions to participants, (3) maintaining and distributing the standards, and (4) collecting and comparing the data.

Each participating laboratory will receive for calibration one of each of the three standard samples from the project organizer. The same three samples will be destributed sequentially to all participants in order to assist in separating technique errors from specimen errors. Detailed instructions regarding the kind and quantity of data required to make the comparison of results from different laboratories meaningful will be provided. Basically, data will be required that fully characterize (1) the geometry of the small-angle collimation system, (2) the X-ray generator and the focal spot, (3) the X-ray wavelength and monochromatization, and (4) the X-ray detection system. These data will be recorded on forms provided. Detailed descriptions of the calibration techniques and all raw data will be recorded. Equations and sample calculations for the data reduction must be shown, including the method of collimation corrections if any is used. The final result – the absolute differential X-ray scattering cross section for each sample will be used to compare the results from the different laboratories. The data from participants will be analyzed with the assistance of L. B. Shaffer and a report prepared for publication. Complete anonymity of all participants will be maintained.

The standard samples and their mounts and the detailed instructions for participation are now being prepared and checked. All interested researchers are encouraged to communicate with the project organizer (address below) for further details.

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## **Notes and News**

Announcements and other items of crystallographic interest will be published under this heading at the discretion of the Editorial Board. The notes (in duplicate) should be sent to the Executive Secretary of the International Union of Crystallography (J. N. King, International Union of Crystallography, 13 White Friars, Chester CH1 1NZ, England).

## Conference on Frameword Silicates and Metals Cambridge (England), 10 December 1971

The Crystallography Group of The Institute of Physics and The Physical Society and The Mineralogical Society are jointly holding a one-day meeting at the Cavendish Laboratory, Cambridge, in honour of Dr W. H. Taylor, who will retire from the position of Reader in Crystallography in September 1971. The meeting will have two sessions on topics which have been of particular interest to Dr Taylor;

in the morning the session will be devoted to *Framework Silicates* and in the afternoon the topic will be *Metals*. A Conference Dinner will be held in St John's College on the evening of 10 December.

Further information and registration forms will be available through the two societies. Accommodation for the nights of 9 and 10 December (if required) will be provided in a College. The Local Secretary (Dr P. Gay, Department of Mineralogy and Petrology, Downing Place, Cambridge, England) will be pleased to give advice to prospective participants.